

Notice of References Cited	Application/Control No. 09/935,780	Applicant(s)/Patent Under Reexamination FANG ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,206,858	04-1993	Nakano et al.	370/465
*	B	US-6,963,564	11-2005	Liu, Heyun H.	370/389
*	C	US-5,280,476	01-1994	Kojima et al.	370/397
*	D	US-5,414,702	05-1995	Kudoh, Norimasa	370/395.7
*	E	US-5,446,726	08-1995	Rostoker et al.	370/232
*	F	US-5,467,342	11-1995	Logston et al.	370/253
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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